Applicant(s)/Patent Under Application/Control No. Reexamination 10/042,367 BEYER ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Sam Rimell 2175

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6516312	02-2003	Kraft et al.	707/3
	В	US-US2003/0115189	06-2003	Srinvasa et al.	707/3
	С	US-6665658	12-2003	DaCosta et al.	707/3
	D	US-US2003/0088544	05-2003	Kan et al.	707/3
	E	US-6363377	03-2002	Kravets et al.	707/4
	F	US-US2001/0032205	10-2001	Kubaitis	707/10
	G	US-6119101	09-2000	Peckover	705/10
	Н	US-			
	ī	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

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